2016 High P-sum with z_0 Cut

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The cut on z_0 has seen good performance in background rejection while maintaining good efficiency on macroscopically displaced vertices from the SIMP signal process.

Hope

Maybe this cut can provide improved sensitivity of HPS to the "vanilla" dark photon model. $e^-N \rightarrow e^-NA' \rightarrow e^-Ne^-e^+$

Goal

Follow same procedure for estimating sensitivity as prior displaced vertex analysis but using the new samples and the SIMP control region (High P-Sum) cuts.



For a given ϵ and $m_{A'}$, assuming we haven't discovered signal events, we need the **expected** signal that we "should" have seen and the maximum signal allowed by the (presumably signal-less) data.

- $\blacksquare \text{ Mass Resolution } \sigma$
- Radiative Fraction f_{rad}
- Trident Differential Production dN_{γ^*}/dm_{reco}

$$N_{\text{prompt}} = \epsilon^2 \frac{N_{\text{prompt}}}{\epsilon^2} = \epsilon^2 \left(\frac{3\pi}{2\alpha} m_{A'} f_{\text{rad}} \frac{dN_{\gamma^*}}{dm_{\text{reco}}} \right) \quad \text{and} \quad c\tau = \frac{\alpha}{3\epsilon^2} m_{A'} \left(1 + 2\frac{m_e^2}{m_{A'}^2} \right) \sqrt{1 - 4\frac{m_e^2}{m_{A'}^2}}$$





Used displaced dark photon samples and the SIMP Control Region (High P-sum) selection

Observe resolution behaving similar to that reported by Matt in the 2016 Displaced Vertex Note and only slight worsening compared to bump hunt reported by Rafo





$$f_{
m rad} = rac{dN_{\gamma^*}}{rac{dN_{
m true}}{dN_{
m bkgd}}}
ightarrow rac{N_{
m rad}}{N_{
m wab} + N_{
m tritrig}}$$

- Used same Tri-Trig, WAB, and Radiative MC samples as being used within SIMP analysis
- Not identical fit, but main separation is in region where HPS does not have sensitivity anyways due to total trident production rate.

Trident Differential Production



100% 2016 data sample within SIMP CR
 Following shape and magnitude of previous estimates



HEAVY PHOTON



Only **minor** differences in ingredients so far which can largely be blamed on differences in samples.

Cuts

- $\blacksquare P_{\rm sum} > 1.9 ~{\rm GeV}$
- L1 Requirement for both tracks in event
- Exactly one vertex in event
- Significance of Vertex Projection to Target < 2.0
- $m_{A'} 1.25\sigma < m_{\rm reco} < m_{A'} + 1.25\sigma$
- $z > z_{target}$
- $|z_0|/mm > 1.08 7.44 \times 10^{-3} (m_{\rm reco}/{\rm MeV}) + 1.59 \times 10^{-5} (m_{\rm reco}/{\rm MeV})^2$
- $\Delta z/mm < 21.2 + 0.166 (m_{reco}/MeV)$

Following same procedure from original note.

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Expected Signal





- Peaking around 0.3 as is seen in the original result
- Similar mass and ϵ region as well

Max Signal Allowed





- As estimated by OIM using the signal distribution over *z* as the CDF to cast events in *z* into uniformly-distributed events in some variable *X*.
- Not too much out of the ordinary besides a mass bin that has a few surprising events within it leading to higher-than-average maximum allowed.

Result





- Again, similar to previous result for L1L1 only.
- Do not have access to original result and so I cannot make a more quantitative comparison.

Questions



Need to re-weight events by their z such that passing fraction represents the number of expected signal at that decay distance.

$$D(z) = rac{\epsilon^2}{\langle \gamma
angle c au_{\epsilon=1}} \exp\left[rac{(z_{ ext{target}} - z)\epsilon^2}{\langle \gamma
angle c au_{\epsilon=1}}
ight]$$

To explain the expected signal calculation procedure, let's walk through an example for $m_{A'} = 100 \text{MeV}$.

Decay Weights





Selection Efficiency over z





- How likely a given signal event passes the selection criteria
- Includes factors for readout acceptance and analysis acceptance

But readout acceptance is already accounted for within the data-driven estimate of the trident differential production rate. \Rightarrow Re-scale F(z) so that it equals 1 at the target.

Re-Scaled Selection Efficiency over z





- Calculate β by averaging over the four bins nearest the target
- Puts the pre-selection distribution near 1 within statistical uncertainty at the target.

Result





- Combining \(\beta F(z)\) and \(D(z)\) gives us the integral we should sum over to obtain the probability a given produced signal event remains within acceptance
- Multiplying this probability by the total number of produced signal (as estimated by the trident differential production) gives an estimate for the expected number of signal events.



Re-Evaluate 2016 Mass Resolution

Due to a variety of simulation and reconstruction patches and updates.

Signal samples generated and reconstructed by Cam

Added to sample list for Pass4b on confluence Pass4b for 2016 MC

Applied momentum smearing with hpstr

- Code in hpstr PR 187
- Plotted and fit in notebook

Selecting vertices whose tracks have been strictly matched to truth-level "rad" electrons (i.e. not contaminated with recoil electrons)

More Similar Selection





- Reduction in low-side tail distorting results
- Resulting resolution σ still deviating more from previous estimate, but at a much smaller scale





Figure 28: Mass distribution for 75 MeV A' MC. Left: unsmeared mass, right: smeared mass

Figure: From Rafo's 2016 Bump Hunt Internal Note end of Section 4.

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2016 Re-Exclusion



150

- Able to use newer generated samples to produce mass resolution estimates including track smearing
- Observing slight worsening in resolution (increase in σ) compared to previous estimate

75

100

125

50

Resolution (σ) [MeV]

2

25

Mass (µ) [MeV]

175

200





- **Goal** : Center (mean μ) and Width (std dev σ) of peak
- Two stage process
- 1. Find Peak
- Iterative approach
 - 1. Calculate μ and σ from the bins
 - 2. Remove bins further than N\sigma away from μ
 - 3. Repeat until stable (i.e. no bins are being removed)
- For the results here, I chose N = 2.
- 2. Fit Normal Distribution
 - Actually fitting a "scaled" normal distribution which is just a normal distribution multiplied by some scale (basically ends up being the integral of the fit range if fit is good).
 - Only fitting to the range of bins selected in Stage 1 above.
 - Using uncertainty on bin content as errors of data points in fit.
 - \blacksquare μ and σ taken from this fit.

2016 Re-Exclusion

Direct Testing of Smearing Tool

Manually constructing tracks with known input momenta and then applying smearing.

 \checkmark Get expected results \checkmark



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Mass Extrema





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SIMP CR

- 1. L1 Requirement
- 2. $P_{sum} > 1.9 \text{ GeV}$
- 3. Electron matched to truth rad electron
- 4. Single Vertex Candidate

SIMP SR

- 1. L1 Requirement
- 2. $P_{sum} < 1.9 \text{ GeV}$
- 3. $P_{sum} > 1.0 \text{ GeV}$
- 4. Electron matched to truth rad electron
- 5. Single Vertex Candidate

Rafo Tables 4 and 7

- $1. \ {\sf Preselection}$
 - > $\chi^2 < 12$, Goodness of PID < 10, cluster-track time diff < 6 ns for both tracks
 - > Electron track has P < 2.15 GeV
- 2. $P_{sum} < 2.4 \text{ GeV}$
- 3. $P_{sum} > 1.9 \text{ GeV}$
- 4. $|\Delta t_{cluster}| < 1.43$ ns
- 5. Single Vertex Candidate

